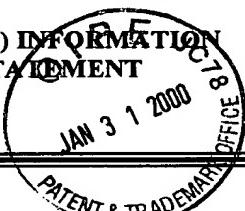


<b>Subst. Form PTO-1449</b> <b>APPLICANT(S') INFORMATION DISCLOSURE STATEMENT</b> 		<b>Atty. Docket No.:</b> XER 2 0308 D/98721		<b>Serial No.:</b> 09/449,321			
		<b>Applicant(s):</b> Gregg A. Bonikowski et al.					
		<b>Filing Date:</b> November 24, 1999		<b>Group:</b> 2852			
<b>U.S. PATENT DOCUMENTS</b>							
Initial*		Document No.	Date	Name	Class	Subcl.	Filing Date
JF	AA	4,480,545	06 Nov 1984	N. Fujisawa et al.			07 Jun 1983
JF	AB	5,289,768	01 Mar 1994	James J. Keller			15 Mar 1993
JF	AC	5,553,216	03 Sep 1996	M. Yoshioka et al.			24 Feb 1994
JF	AD	5,555,803	17 Sep 1996	Helmut Holm			21 Jun 1995
JF	AE	5,559,606	24 Sep 1996	M. W. Webster et al.			28 Nov 1995
JF	AF	5,604,600	18 Feb 1997	Marc W. Webster			06 Dec 1995
JF	AG	5,606,395	25 Feb 1997	Eugene L. Yang			11 Jan 1996
JF	AH	5,617,215	01 Apr 1997	M. W. Webster et al.			06 Dec 1995
JF	AI	5,631,740	20 May 1997	M. W. Webster et al.			28 Nov 1995
JF	AJ	5,638,752	17 Jun 1997	G. Hartung et al.			27 Jul 1995
JF	AK	5,646,740	08 Jul 1997	M. W. Webster et al.			06 Dec 1995
JF	AL	5,682,247	28 Oct 1997	M. W. Webster et al.			06 Dec 1995
JF	AM	5,701,557	23 Dec 1997	M. W. Webster et al.			28 Nov 1995
JF	AN	5,710,635	20 Jan 1998	M. W. Webster et al.			06 Dec 1995
	AO						
<b>FOREIGN PATENT DOCUMENTS</b>							
		Document No.	Date	Country	Class	Subcl.	Translation?
	AP						
<b>OTHER ART</b>							
	AR						
	AS						
	AT						
Examiner: <i>Justin Tronto</i>				Date Considered: <i>7/25/03</i>			
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